

AdAM: Adaptive Approximate Multiplier for Fault Tolerance in DNN Accelerators

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AdAM: adaptive fault-tolerant approximate multiplier for edge DNN accelerators

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Special session: reliability assessment recipes for DNN accelerators

Ahmadilivani, Mohammad Hasan; Bosio, Alberto; Deveautour, Bastien; Dos Santos, Fernando Fernandes; Guerrero-Balaguera, Juan-David; **Jenihhin, Maksim;** Kritikakou, Angeliki; Sierra, Robert Limas; **Raik, Jaan; Taheri, Mahdi** 42nd IEEE VLSI Test Symposium, VTS 2024 2024 / 11 p. : ill <https://doi.org/10.1109/VTS60656.2024.10538707> [Conference proceedings at Scopus](#) [Article at Scopus](#) [Article at WOS](#)

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